

<b>Notice of References Cited</b>	Application/Control No. 10/779,858		Applicant(s)/Patent Under Reexamination MEYER, FRANK	
	Examiner Tomasz Ponikiewski		Art Unit 2165	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0115175 A1	06-2003	Baatz et al.	707/1
	B	US-			
	C	US-			
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